Notice of References Cited Application/Control No. 10/628,058 Examiner Huyen X. Vo Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-6,804,639	10-2004	Ehara, Hiroyuki	704/223	
	В	US-				
	С	US-				
	D	US-				
	ш	US-				
	F	US-				
	G	US-				
	Ι	US-				
	_	US-				
	٦	US-				
	K	US-				
	L	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	0					
	Р					
	s					
	Т					

NON-PATENT DOCUMENTS

	NON- ATEN DOCUMENTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
1	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.